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Sheet 1

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

Complete if Known				
Application Number	10/827,252			
Filing Date	April 20, 2004	;		
First Named Inventor	Mohiuddin Mala			
Art Unit	2873			
Examiner Name	William C. Choi	<del></del>		
Attorney Docket Number	14682			

U.S. PATENT DOCUMENTS						
Examiner Initials *	Cite No. 1	Document Number  Number-Kind code <sup>2</sup> (If known)	Publication Date MM-DD-YYY	Name of Patentee or Applicant of Cited Document	Page, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
WC	AA	US-6,454,421 B2	Sep. 24, 2002	Yu et al.		
<u> </u>	AB	US-2002/0012180 A1	Jan. 31, 2002	Yu et al.		
	AC	US-6,315,423 B1	Nov. 13, 2001	Yu et al.		
	AD	US-5,579,148	Nov. 26, 1996	Nishikawa et al.		
	AE	US-6,984,917 B2	Jan. 10, 2006	Greywall et al.		
7/7	AF	US-6,690,850 B1	Feb. 10, 2004	Greywall		
$-\Psi$	AG	US-6,392,220	May 21, 2002	Slater et al.		
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		FOREIG	N PATENT DOC	UMENTS		
Examiner Initials *	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages	
muais	No. 1	Country Code <sup>3</sup> Number <sup>4</sup> Kind Code <sup>5</sup> (if known)	MM-DD-YYYY		Or Relevant Figures Appear	۲٥
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1	Examiner	/William Choi/	Date	06/23/2006
1	Signature	,	Considered	·

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Translation is attached.

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## **INFORMATION DISCLOSURE** STATEMENT BY APPLICANT

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Sheet 2

Complete if Known			
Application Number	10/827,252		
Filing Date	April 20, 2004		
First Named Inventor	Mohiuddin Mala		
Art Unit	2873	•	
Examiner Name	William C. Choi		
Attorney Docket Number	14682		

F la a a	1 04-	NON PATENT LITERATURE DOCUMENTS  Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of	T
Initials * No. 1 the item (book, magazine, journal, serial, symposium, catalog, etc.), date, pages), volume-iss number(s), publisher, city and /or country where published.		Τ <sup>2</sup>	
WC AH		Johanna I. Young, et al.; COMPARATIVE STUDY OF 2-DOF MICROMIRRORS FOR PRECISION LIGHT MANIPULATION; SPIE Smart Structures and Materials Conference, Newport Beach, CA, March 4-7, 2001.	
	Al	Velijko Milanovic, et al.; MONOLITHIC HIGH ASPECT RATIO TWO-AXIS OPTICAL SCANNERS IN SOI; 2003 MEMS Conference, Kyoto, Japan, January 19-23, 2003, pp. 255-258.	0
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I	Examiner Signature	/William Choi/	Date Considered	06/23/2006
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